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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

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ALEXANDER J. PASADYN

Group Art Unit: 2823

Examiner: KHIEM D. NGUYEN

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Atty. Dkt.: 2000.075200/TT4629  
CUSTOMER NO.: 23720For: METHOD AND APPARATUS  
FOR CONTROLLING A  
THICKNESS OF A CONDUCTIVE  
LAYER IN A SEMICONDUCTOR  
MANUFACTURING OPERATION

PLEASE ENTER

K.W.

03/08/05

RESPONSE TO FINAL OFFICE ACTION OF JANUARY 5, 2005Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

CERTIFICATE OF TRANSMISSION UNDER 37 C.F.R. 1.6(D)	
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I hereby certify that this paper or fee is being facsimile to the United States Patent and Trademark Office to the facsimile number noted above.	
<i>Kathryn Monos</i> Signature	

This paper is submitted in response to the Office Action mailed January 5, 2005 for which the shortened three-month statutory response date is April 5, 2005.

Remarks begin on page 3 of this paper.

If an extension of time is required to enable this paper to be timely filed and there is no separate Petition for Extension of Time filed herewith, this paper is to be construed as also constituting a Petition for Extension of Time Under 37 CFR § 1.136(a) for a period of time sufficient to enable this document to be timely filed.